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Front Matter: Volume 11725

, "Front Matter: Volume 11725," Proc. SPIE 11725, Next-Generation Spectroscopic Technologies XIV, 1172501 (12 May 2021); doi: 10.1117/12.2598700

Event: SPIE Defense + Commercial Sensing, 2021, Online Only

PROCEEDINGS OF SPIE

Next-Generation Spectroscopic Technologies XIV

**Luisa T. M. Profeta
John F. O'Hara
Steven M. Barnett**
Editors

**12–16 April 2021
Online Only, United States**

Sponsored and Published by
SPIE

Volume 11725

Proceedings of SPIE 0277-786X, V. 11725

SPIE is an international society advancing an interdisciplinary approach to the science and application of light.

Next-Generation Spectroscopic Technologies XIV, edited by Luisa T. M. Profeta, John F. O'Hara,
Steven M. Barnett, Proc. of SPIE Vol. 11725, 1172501 · © 2021 SPIE
CCC code: 0277-786X/21/\$21 · doi: 10.1117/12.2598700

Proc. of SPIE Vol. 11725 1172501-1

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Author(s), "Title of Paper," in *Next-Generation Spectroscopic Technologies XIV*, edited by Luisa T. M. Profeta, John F. O'Hara, Steven M. Barnett, Proc. of SPIE 11725, Seven-digit Article CID Number (DD/MM/YYYY); (DOI URL).

ISSN: 0277-786X
ISSN: 1996-756X (electronic)

ISBN: 9781510642874
ISBN: 9781510642881 (electronic)

Published by
SPIE
P.O. Box 10, Bellingham, Washington 98227-0010 USA
Telephone +1 360 676 3290 (Pacific Time)
SPIE.org
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